

	ATTY DOCKET NO. MEM-0004	SERIAL NO. 10/811,466
	Wu, et al.	
	FILING March 26, 2004	GROUP

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	4,631,094	12/23/1986	Simpson, et al.			
	4,740,253	4/26/1988	Simpson, et al.			
	4,770,725	9/13/1988	Simpson, et al.			
	5,409,460	4/25/1995	Krumme			
	5,843,244	12/1/1998	Pelton, et al.			
	6,258,182	7/10/2001	Schetky, et al.			
	6,375,458	4/23/2002	Moorlegghem, et al.			
	6,509,094	1/21/2003	Shah, et al.			
	6,514,261	2/4/2003	Randall, et al.			
	6,530,947	3/11/2003	Euteneuer, et al.			
	2003/0060802	3/27/2003	Omaleki, et al.			

FOREIGN PATENT DOCUMENTS

DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
					YES	NO
WO 01/86096	15.11.2001	PCT				
EP 0 185 452	06.11.1985	Europe				

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER	DATE CONSIDERED
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INFORMATION DISCLOSURE CITATION <i>(Use several sheets if necessary)</i>	ATTY DOCKET NO. MEM-0004	SERIAL NO. - QAO. 3734 10/811,466
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	2003/0065346	4/3/2003	Evens, et al.			
	2003/0065377	4/3/2003	Davila, et al.			

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DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
					YES	NO

OTHER DOCUMENTS *(Including Author, Title, Date, Pertinent Pages, Etc.)*

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